

Part Number

Customer

Category		Parameter	Specification	Measurement Method
OverallWafer	1.0	Diameter	100.00 +/- 0.20 mm	
	2.0	Primary Flat Orientation	{110} +/- 0.5 degree	Wafer Vendor
	3.0	Primary Flat Length	32.50 +/- 2.50 mm	Wafer Vendor
	4.0	Secondary Flat Orientation	none/semi standard	
	5.0	Overall Thickness	330.00 +/- 10.00 μ m	ADE, 100%
	6.0	Total Thickness Variation (TTV)	<2.00 μ m	Guaranteed by Process
	7.0	Bow	<100.00 μ m	Estimate- ADE to ASTM F534, 20%
	8.0	Warp	<100.00 μ m	Estimate- ADE to ASTM F657, 20%
	9.0	Edge Chips	0	Bright Light, 100% (note 2)
	10.0	Edge Exclusion	3mm	
HandleSilicon	11.0	Handle Growth Method	CZ	Wafer Vendor
	12.0	Handle Orientation	{100} +/- 0.5 degree	Wafer Vendor
	13.0	Handle Thickness	315.00 +/- 5.00 μ m	ADE, 100%
	14.0	Handle Doping Type	N	Wafer Vendor
	15.0	Handle Dopant	Antimony	Wafer Vendor
	16.0	Handle Resistivity	0.01 ~ 0.025 Ohmcm	Wafer Vendor
	17.0	Backside Finish	Polished with light handling marks & Lasermark	Guaranteed by process
	18.0	Backside scratches	Light Handling marks	Bright Light, 100% (note 2)
	19.0	Total scratch length	Frontside - Total <10mm.	Bright Light, 100% (note2)
	20.0	Surface Haze	none	Bright Light, 100% (note 2)
OverallWafer	21.0	Backside Laser Marking Type	Scribe by DOT MATRIX	
	22.0	Frontside final oxide thickness	10.00 +/- 1.00 μ m	Centre point, 4%

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Shipping Details	Wafer per box :	Max 25	
	Packaging :	Taped Polypropylene Wafer Box Empak, Ultrapak, 100.00mm Antistatic Double Bagging	
	Lot Shipment Data	Device Thickness Bow / Warp Data Handle and SOI Thickness	

Explanatory Notes	1. Microscope inspection performed using microscope scan as below. 5x objective.		
	2. All bright light inspections performed exclude all wafer area outside the edge exclusion defined in Overall Wafer, Edge Exclusion. High intensity bright lamp inspection as per ASTM F523.		
	3. 9 point measurement are as shown in the diagram below:		



Additional Information